

MOSFET

Metal Oxide Semiconductor Field Effect Transistor

Bare Die

OptiMOS™3 Power MOS Transistor Chip IPC173N10N3

Data Sheet

Rev. 2.5 Final



IPC173N10N3

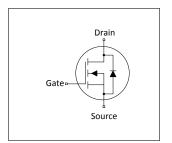
1 Description

- N-channel enhancement mode
- For dynamic characterization refer to the datasheet of IPP045N10N3 G
- AQL 0.65 for visual inspection according to failure catalogue
- Electrostatic Discharge Sensitive Device according to MIL-STD 883C
- Die bond: soldered or glued
- Backside metallization: NiV system
- Frontside metallization: AlCu system
- Passivation: nitride (only on edge structure)



Table 1 Rey 1 chomianoc 1 arameters					
Parameter	Value	Unit	Unit		
$V_{(BR)DSS}$	100	V			
R _{DS(on)}	4.51)	mΩ			
Die size	5.762 x 3.0	mm ²			
Thickness	220	μm			











Type / Ordering Code	Package	Marking	Related Links
IPC173N10N3	Chip	not defined	-

2 Electrical Characteristics on Wafer Level

at $T_i = 25$ °C, unless otherwise specified

Table 2

Davamatav	Symbol		Values		l lmit	Note / Took Condition
Parameter		Min.	Тур.	Max.	Unit	Note / Test Condition
Drain-source breakdown voltage	V _{(BR)DSS}	100	-	-	V	V _{GS} =0 V ,I _D =1 mA
Gate threshold voltage	V _{GS(th)}	2	2.7	3.5	V	V _{DS} =V _{GS} , I _D =150 μA
Zero gate voltage drain current	I _{DSS}	-	0.1	1	μΑ	V _{GS} =0 V ,V _{DS} =100 V
Gate-source leakage current	I _{GSS}	-	1	100	nA	V _{GS} =20 V ,V _{DS} =0 V
Drain-source on- resistance	R _{DS(on)}	-	3.6 ²⁾	100 ³⁾	mΩ	V _{GS} =10 V ,I _D =2.0 A
Reverse diode forward on-voltage	V _{SD}	-	0.7	1.2	V	V _{GS} =0 V ,I _F =1A
Avalanche energy, single pulse	E AS	_	45 ⁴⁾	-	mJ	I_D =30 A, R_{GS} =25 Ω

¹⁾ packaged in a P-TO220-3 (see ref. product)

²⁾ typical bare die $R_{\rm DS(on)}$; $V_{\rm GS}$ =10 V

³⁾ limited by wafer test-equipment

⁴⁾ Wafer tested. For general avalanche capability refer to the datasheet of IPP045N10N3 G



3 Package Outlines

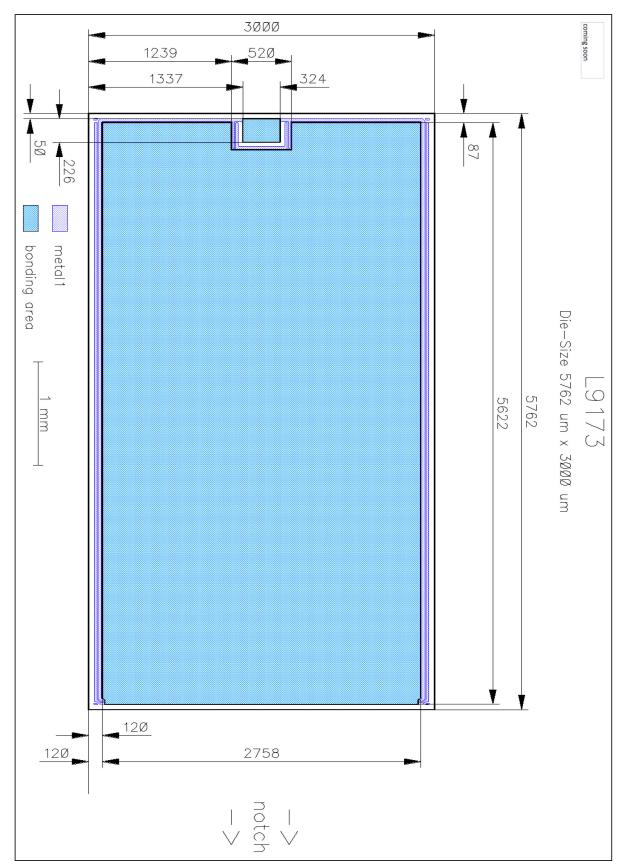


Figure 1 Outline Chip, dimensions in µm



OptiMOS™3 Power MOS Transistor Chip

IPC173N10N3

Revision History

IPC173N10N3

Revision: 2014-07-25, Rev. 2.5

Previous Revision

Revision	Date	Subjects (major changes since last revision)	
2.5	2014-07-25	Release of Final Version	

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